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QUERY CONTROL FORM		RTIS USE ONLY
Application No. 09 925,102	Prepared by	Tracking Number 05888489
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a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449		
b. Applicant(s)	g. Disclaimer	I. Print Fig.	q. PTOL-85b		
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract		
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs		
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other		

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT					Applicant(s)		REC	EIVE
(Use several sheets if necessary)					Jack H. Yu	an et al.	JUL 3	0 20
					Filing Date	,	Chibilogy Center	
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xaminer nitial	ADEMIC:	Document Number	Date	Name	Class	Subclass	Filing I	
PP	AP		Nov. 21, 2000	Harari et al.	0.000			<u></u>
PP	AQ		Apr. 24, 2001	Guterman et al.			<u> </u>	
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	<u></u>	OTHER ART	(Including A	utbor, Title, Date, Per	tinent Pages,	Etc.)	<u> </u>	
Ph	AR -	Nozaki et al., "A 1-N IEEE Journal of Sol	Mb EEPROM vid State Circuit	with MONOS Memory s, Vol. 26, No. 4, Apri	Cell for Semical 1991, pp. 497	conductor Disk 7-501.	Application	,"
PO.	AS-	Eitan et al., "NROM Device Letters, Vol.	Eitan et al., "NROM: A Novel Localized Trapping, 2-Bit Nonvolatile Memory Cell," <i>IEEE Electron Device Letters</i> , Vol. 21, No. 11, November 2000, pp. 543-545.					
	AT	DiMaria et al., "Elec	trically-alterat	ole read-only-memory	using Si-rich S	10 ₂ injectors an	d a floating	
PΩ	^'	polycrystalline silico	on storage layer	r," J. Appl. Phys. 32(1)	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		•	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

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.S. Departme	ent of Con	nt of Commerce, Patent and Trademark Office				et No.	Serial No		
						M-11822 US			
O INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Applicant(s)					
	(Use several sheets if necessary)					Jack H. Yuan et al.			
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TRADEM		· ·	U.S. P	atent Documents					
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing I		
P7	AA	5,043,940	Aug. 27, 1991	Harari			RECEI		
1	AB	5,070,032	Dec. 3, 1991	Yuan et al.					
	AC	5,095,344	Mar. 10, 1992	Harari			AAF 9-0	2002	
_	AD	5,172,338	Dec. 15, 1992	Mehrotra et al.		Tecl	nology Cen	ter 2	
	AE	5,297,148	Mar. 22, 1994	Harari et al.					
	AF	5,313,421	May 17, 1994	Guterman et al.			1		
+	AG	5,315,541	May 24, 1994	Harari et al.					
+,	AH	5,343,063	Aug. 30, 1994	Yuan et al.	1		1		
1/-	Al	5,661,053	Aug. 26, 1997	Yuan			1 .		
W	AJ	5,712,180	Jan. 27, 1998	Guterman et al.					
PD:	AK	6,103,573	Aug. 15, 2000	Harari et al.					
			Foreign	Patent Documents					
							Tran	ıslatio	
		Document	Date	Country	Class	Subclass	Yes	No	
						<u> </u>	<u> </u>		
•		OTHER A	RT (Including A	thor, Title, Date, Per	tinent Pages,	Etc.)			
PD	AL.	Aritome, Seiichi, Technical Digest 10-13, 2000, pp.	, International Ele	Memory Technology a ctronic Devices Meetin	and Trends for ng, IEEE, San	File Storage A Francisco, Cali	opplication," fornia, Dece	IEDM mber	
PD	AM,	Takeuchi, Y., et al., "A Self-Aligned STI Process Integration for Low Cost and Highly Reliable 1Gbit Flash Memories," 1998 Symposium on VLSI Technology; Digest of Technical Papers, IEEE, Honolulu, Hawaii, June 9-11, 1998, pp. 102-103.							
	AN·	Lee, Jae-Duk, et al., "Effects of Parasitic Capacitance on NAND Flash Memory Cell Operation," Non-Volatile Semiconductor Memory Workshop, IEEE, Monterey, California, August 12-16, 2001, pp. 90-92.							
PD									
PD PP:	A0-	Chan, et al., "A 7	Frue Single-Transi L-8, No. 3, March	stor Oxide-Nitride-Oxi 1987, pp. 93-95.		Device, " <i>IEE</i> .	E Electron D	evice	

Express Mail Label No.: EL947771704US

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INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)				Atty. Docket No.	Atty. Docket No.		Serial No.			
				C000400		09/950,959				
				Applicant Robert L. Dickerman et al.						
				Filing Date September 12, 2			Group 2858			
- Of tracking			U.S. PATE	NT DOCUMENTS						
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing D			
PO		4,914,378	4/90	Hayashi et al.						
PD		4,656,595	4/87	Hognestad		·				
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		F	OREIGN PA	ATENT DOCUMEN	ets.					
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	OT	HER DOCUMEN	TS (Includir	ng Author, Title, Da	te, Per	inent Page, Etc	.)			
PD		PCT International	l Search Rep	ort dated 24/10/2003						
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